## TS3A5018 10- $\Omega$ Quad SPDT Analog Switch

## 1 Features

- Low ON-State Resistance (10 $\Omega$ )
- Low Charge Injection
- Excellent ON-State Resistance Matching
- Low Total Harmonic Distortion (THD)
- $1.8-\mathrm{V}$ to $3.6-\mathrm{V}$ Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
- 2000-V Human-Body Mode (A114-B, Class II)
- 1000-V Charged-Device Model (C101)


## 2 Applications

- Sample-and-Hold Circuits
- Battery-Powered Equipment
- Audio and Video Signal Routing
- Communication Circuits


## 3 Description

The TS3A5018 device is a quad single-pole doublethrow (SPDT) analog switch that is designed to operate from 1.8 V to 3.6 V . This device can handle digital and analog signals, and signals up to $\mathrm{V}_{+}$can be transmitted in either direction.

| Device Information $^{(1)}$ |  |  |
| :--- | :--- | :--- |
| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
| TS3A5018 | SOIC $(16)$ | $9.90 \mathrm{~mm} \times 6.00 \mathrm{~mm}$ |
|  | $\operatorname{SSOP}(16)$ | $6.00 \mathrm{~mm} \times 4.90 \mathrm{~mm}$ |
|  | TSSOP $(16)$ | $5.00 \mathrm{~mm} \times 4.40 \mathrm{~mm}$ |
|  | TVSOP $(16)$ | $4.40 \mathrm{~mm} \times 3.60 \mathrm{~mm}$ |
|  | UQFN $(16)$ | $2.50 \mathrm{~mm} \times 1.80 \mathrm{~mm}$ |
|  | VQFN $(16)$ | $4.00 \mathrm{~mm} \times 3.50 \mathrm{~mm}$ |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Block Diagram


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Changes from Revision G (March 2015) to Revision H Page

- Changed the pinout images ..... 3
- Changed the $r_{\text {on }}$ MAX value at $25^{\circ} \mathrm{C}$ From: $8 \Omega$ To: $17 \Omega$ in the Electrical Characteristics for $1.8-\mathrm{V}$ Supply table. ..... 7
- Changed the $r_{\text {on }}$ MAX value at Full From: $14.55 \Omega$ To: $32 \Omega$ in the Electrical Characteristics for 1.8-V Supply table ..... 7
Changes from Revision F (June 2013) to Revision G ..... Page
- Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section ..... 1
- Deleted Ordering Information table. ..... 1


## 5 Pin Configuration and Functions



Pin Functions

| PIN |  |  | TYPE | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: |
| NAME | SOIC, SSOP, TVSOP, VQFN NO. | UQFN NO. |  |  |
| COM1 | 4 | 2 | I/O | Common path for switch |
| COM2 | 7 | 5 | I/O | Common path for switch |
| COM3 | 9 | 7 | I/O | Common path for switch |
| COM4 | 12 | 10 | I/O | Common path for switch |
| $\overline{\mathrm{EN}}$ | 15 | 13 | 1 | Active-low switch enable input |
| GND | 8 | 6 | - | Ground |
| IN | 1 | 15 | 1 | Switch path selector input |
| NC1 | 2 | 16 | I/O | Normally closed path for switch |
| NC2 | 5 | 3 | I/O | Normally closed path for switch |
| NC3 | 11 | 9 | I/O | Normally closed path for switch |
| NC4 | 14 | 12 | I/O | Normally closed path for switch |
| NO1 | 3 | 1 | I/O | Normally open path for switch |
| NO2 | 6 | 4 | I/O | Normally open path for switch |
| NO3 | 10 | 8 | 1/O | Normally open path for switch |
| NO4 | 13 | 11 | I/O | Normally open path for switch |
| V+ | 16 | 14 | - | Supply voltage |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ${ }^{(1)(2)}$

|  |  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{+}$ | Supply voltage ${ }^{(3)}$ |  | -0.5 | 4.6 | V |
| $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \\ & \mathrm{~V}_{\mathrm{NO}} \\ & \mathrm{~V}_{\mathrm{COM}} \\ & \hline \end{aligned}$ | Analog voltage ${ }^{(3)(4)}$ |  | -0.5 | 4.6 | V |
| $\mathrm{I}_{\mathrm{K}}$ | Analog port diode current | $\mathrm{V}_{\mathrm{NC}}, \mathrm{V}_{\mathrm{NO}}, \mathrm{V}_{\mathrm{COM}}<0$ | -50 |  | mA |
| $I_{N C}$ <br> $\mathrm{I}_{\mathrm{NO}}$ <br> $\mathrm{I}_{\mathrm{COM}}$ | ON-state switch current | $\mathrm{V}_{\mathrm{NC}}, \mathrm{V}_{\mathrm{NO}}, \mathrm{V}_{\mathrm{COM}}=0$ to 7 V | -64 | 64 | mA |
| $\mathrm{V}_{1}$ | Digital input voltage ${ }^{(3)(4)}$ |  | -0.5 | 4.6 | V |
| $\mathrm{I}_{\mathrm{IK}}$ | Digital input clamp current | $\mathrm{V}_{1}<0$ | -50 |  | mA |
| $\mathrm{I}_{+}$ | Continuous current through $\mathrm{V}_{+}$ |  | -100 | 100 | mA |
| $\mathrm{I}_{\text {GND }}$ | Continuous current through GND |  | -100 | 100 | mA |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature |  | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum
(3) All voltages are with respect to ground, unless otherwise specified.
(4) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

### 6.2 ESD Ratings

| $\mathrm{V}_{(\text {(ESD })} \quad$ Electrostatic discharge |  |  | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ${ }^{(1)}$ |
| :--- | :--- | :---: | :---: |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|  |  | MIN | MAX |
| :--- | :--- | ---: | ---: |
| $\mathrm{V}_{\text {IO }}$ | Switch input and output voltage | 0 | $\mathrm{~V}_{+}$ |
| $\mathrm{V}_{+}$ | Supply voltage | V |  |
| $\mathrm{V}_{1}$ | Control input voltage | 1.65 |  |
| $\mathrm{~T}_{\mathrm{A}}$ | Operating temperature | 0 | V |

### 6.4 Thermal Information

| THERMAL METRIC ${ }^{(1)}$ |  | TS3A5018 |  |  |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} \text { D } \\ \text { (SOIC) } \end{gathered}$ | $\begin{aligned} & \hline \text { DBQ } \\ & \text { (SSOP) } \end{aligned}$ | $\begin{gathered} \text { DGV } \\ \text { (TVSOP) } \end{gathered}$ | $\begin{gathered} \text { PW } \\ \text { (TSSOP) } \end{gathered}$ | $\begin{gathered} \text { RGY } \\ \text { (VQFN) } \end{gathered}$ | $\begin{aligned} & \text { RSV } \\ & \text { (UQFN) } \end{aligned}$ |  |
|  |  | 16 PINS | 16 PINS | 16 PINS | 16 PINS | 16 PINS | 16 PINS |  |
| $\mathrm{R}_{\text {өJA }}$ | Junction-to-ambient thermal resistance | 73 | 90 | 120 | 108 | 51 | 184 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 6.5 Electrical Characteristics for 3.3-V Supply

$\mathrm{V}_{+}=3 \mathrm{~V}$ to $3.6 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Analog Switch |  |  |  |  |  |  |  |  |  |
| $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}, \mathrm{~V}_{\mathrm{NO}}, \\ & \mathrm{~V}_{\mathrm{NC}} \end{aligned}$ | Analog signal range |  |  |  |  | 0 |  | $V_{+}$ | V |
| $\mathrm{r}_{\text {on }}$ | ON-state resistance | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 3 V |  | 7 | 10 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 12 |  |
| $\Delta r_{\text {on }}$ | ON-state resistance match between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=2.1 \mathrm{~V}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 3 V |  | 0.3 | 0.8 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 1 |  |
| $\mathrm{r}_{\text {on(flat) }}$ | ON-state resistance flatness | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 3 V |  | 5 | 7 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 8 |  |
| $\mathrm{I}_{\mathrm{NC}(\text { OFF })}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{OFF})}$ | NC, NO <br> OFF leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=1 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{COM}}=3 \mathrm{~V}, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{COM}}=1 \mathrm{~V}, \end{aligned}$ | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 3.6 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
|  |  | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0$ to 3.6 <br> V , <br> $\mathrm{V}_{\text {COM }}=3.6 \mathrm{~V}$ to 0 , <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=3.6 \mathrm{~V}$ to <br> 0 , <br> $\mathrm{V}_{\mathrm{COM}}=0$ to 3.6 V , | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -2 | 0.05 | 2 |  |
|  |  |  |  | Full |  | -10 |  | 10 |  |
| $\mathrm{I}_{\text {Com(OFF) }}$ | COM <br> OFF leakage current | $\mathrm{V}_{\text {Сом }}=1 \mathrm{~V} \text {, }$ <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=3 \mathrm{~V}$, <br> or <br> $\mathrm{V}_{\text {Сом }}=3 \mathrm{~V}$, <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=3 \mathrm{~V}$, | Switch OFF, <br> see Figure 18 | $25^{\circ} \mathrm{C}$ | 3.6 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=0 \text { to } 3.6 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=3.6 \mathrm{~V} \text { to } \\ & 0, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=3.6 \mathrm{~V} \text { to } 0, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=0 \text { to } 3.6 \\ & \mathrm{~V}, \end{aligned}$ | Switch OFF, <br> see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -2 | 0.05 | 2 |  |
|  |  |  |  | Full |  | -10 |  | 10 |  |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{ON})}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{ON})}$ | NC, NO ON leakage current | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=1 \mathrm{~V}$, <br> $\mathrm{V}_{\text {COM }}=$ Open, <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=3 \mathrm{~V}$, <br> $V_{\text {COM }}=$ Open, | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 3.6 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
| $\mathrm{I}_{\text {COM(ON }}$ | COM <br> ON leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=1 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \end{aligned}$ | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 3.6 V | -0.1 | 0.05 | 0.1 |  |
|  |  |  |  | Full |  | -0.2 |  | 0.2 | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  |  | Full |  | 2 |  | $V_{+}$ | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | Full |  | 0 |  | 0.8 | V |
| $\mathrm{I}_{\mathrm{IH}}, \mathrm{I}_{\mathrm{IL}}$ | Input leakage current | $\mathrm{V}_{1}=\mathrm{V}_{+}$or 0 |  | $25^{\circ} \mathrm{C}$ | 3.6 V | -1 | 0.05 | 1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -1 |  | 1 |  |
| $Q_{C}$ | Charge injection | $\begin{aligned} & \mathrm{V}_{\mathrm{GEN}}=0, \\ & \mathrm{R}_{\mathrm{GEN}}=0, \end{aligned}$ | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=0.1 \mathrm{nF}, \\ & \text { see Figure } 26 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 3.3 V |  | 2 |  | pC |
| $\mathrm{C}_{\mathrm{NC} \text { (OFF) }}$, <br> $\mathrm{C}_{\mathrm{NO} \text { (OFF) }}$ | NC, NO OFF capacitance | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{+}$or GND, | Switch OFF, <br> see Figure 20 | $25^{\circ} \mathrm{C}$ | 3.3 V |  | 4.5 |  | pF |
| $\mathrm{C}_{\text {COM (OFF) }}$ | COM OFF capacitance | $\mathrm{V}_{\text {COM }}=\mathrm{V}_{+}$or GND, | Switch OFF, <br> see Figure 20 | $25^{\circ} \mathrm{C}$ | 3.3 V |  | 9 |  | pF |
| $\mathrm{C}_{\mathrm{NC}(\mathrm{ON})}$, $\mathrm{C}_{\mathrm{NO}(\mathrm{ON})}$ | NC, NO ON capacitance | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{+}$or GND, | Switch ON, see Figure 20 | $25^{\circ} \mathrm{C}$ | 3.3 V |  | 16 |  | pF |
| $\mathrm{C}_{\text {COM(ON) }}$ | COM <br> ON capacitance | $\mathrm{V}_{\text {COM }}=\mathrm{V}_{+}$or GND, | Switch ON, see Figure 20 | $25^{\circ} \mathrm{C}$ | 3.3 V |  | 16 |  | pF |

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

## Electrical Characteristics for 3.3-V Supply (continued)

$\mathrm{V}_{+}=3 \mathrm{~V}$ to $3.6 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

|  | PARAMETER | TEST CONDITIONS |  | $\mathrm{T}_{\text {A }}$ | $\mathrm{V}_{+}$ | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{1}$ | Digital input capacitance | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{+}$or GND, | See Figure 20 | $25^{\circ} \mathrm{C}$ | 3.3 V | 3 |  | pF |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega$, | Switch ON, see Figure 22 | $25^{\circ} \mathrm{C}$ | 3.3 V | 300 |  | MHz |
| OISo | OFF isolation | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \end{aligned}$ | Switch OFF, see Figure 23 | $25^{\circ} \mathrm{C}$ | 3.3 V | -48 |  | dB |
| $\mathrm{X}_{\text {TALK }}$ | Crosstalk | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \\ & \hline \end{aligned}$ | Switch ON, see Figure 24 | $25^{\circ} \mathrm{C}$ | 3.3 V | -48 |  | dB |
| $\mathrm{X}_{\text {TALK(ADJ) }}$ | Crosstalk adjacent | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \end{aligned}$ | Switch ON, see Figure 25 | $25^{\circ} \mathrm{C}$ | 3.3 V | -81 |  | dB |
| THD | Total harmonic distortion | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=600 \Omega, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \end{aligned}$ | $\begin{aligned} & \mathrm{f}=20 \mathrm{~Hz} \text { to } 20 \\ & \mathrm{kHz}, \\ & \text { see Figure } 27 \\ & \hline \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 3.3 V | 0.21\% |  |  |
|  | Positive supply current | $V_{1}=V_{\text {d }}$ or GND | Switch ON or OFF | $25^{\circ} \mathrm{C}$ |  | 2.5 | 7 |  |
| ${ }_{+}$ | , supply current | $V_{1}=V_{+}$or $G$ | Switch ON or OFF | Full | 3.6 V |  | 10 | $\mu \mathrm{A}$ |

### 6.6 Electrical Characteristics for 2.5-V Supply

$\mathrm{V}_{+}=2.3 \mathrm{~V}$ to $2.7 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS |  | $\mathrm{T}_{\text {A }}$ | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}, \mathrm{~V}_{\mathrm{NC}}, \\ & \mathrm{~V}_{\mathrm{NO}} \end{aligned}$ | Analog signal range |  |  |  |  | 0 |  | $V_{+}$ | V |
| $r_{\text {on }}$ | ON-state resistance | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-24 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 2.3 V |  | 12 | 20 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 22 |  |
| $\Delta r_{\text {on }}$ | ON-state resistance match between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=1.6 \mathrm{~V}, \\ & \mathrm{I}_{\mathrm{COM}}=-24 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 2.3 V |  | 0.3 | 1 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 2 |  |
| $\mathrm{r}_{\text {on(flat) }}$ | ON-state resistance flatness | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-24 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 2.3 V |  | 14 | 18 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 20 |  |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{OFF})}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{OFF})}$ | NC, NO OFF leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=0.5 \mathrm{~V} \text {, } \\ & \mathrm{V}_{\mathrm{COM}}=2.2 \mathrm{~V}, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=2.2 \mathrm{~V} \text {, } \\ & \mathrm{V}_{\mathrm{COM}}=0.5 \mathrm{~V} \text {, } \end{aligned}$ | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 2.7 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=0 \text { to } 3.6 \mathrm{~V} \text {, } \\ & \mathrm{V}_{\mathrm{COM}}=3.6 \mathrm{~V} \text { to } 0, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=3.6 \mathrm{~V} \text { to } 0, \\ & \mathrm{~V}_{\mathrm{COM}}=0 \text { to } 3.6 \mathrm{~V}, \end{aligned}$ | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -2 | 0.05 | 2 |  |
|  |  |  |  | Full |  | -10 |  | 10 |  |
| $\mathrm{I}_{\text {COM (OFF) }}$ | COM <br> OFF leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=0.5 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=2.2 \mathrm{~V}, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=2.2 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=0.5 \mathrm{~V} \text {, } \end{aligned}$ | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 2.7 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
|  |  | $\mathrm{V}_{\text {COM }}=0$ to 3.6 V , <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=3.6 \mathrm{~V}$ to 0 , <br> or <br> $\mathrm{V}_{\text {Сом }}=3.6 \mathrm{~V}$ to 0 , <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0$ to 3.6 V , | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -2 | 0.05 | 2 |  |
|  |  |  |  | Full |  | -10 |  | 10 |  |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{ON})}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{ON})}$ | NC, NO ON leakage current | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0.5 \mathrm{~V}$, <br> $\mathrm{V}_{\text {COM }}=$ Open, <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=2.2 \mathrm{~V}$, <br> $V_{\text {Com }}=$ Open, | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 2.7 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
| $\mathrm{I}_{\text {COM }}^{\text {(ON })}$ | COM <br> ON leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=0.5 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=2.2 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \end{aligned}$ | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 2.7 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.2 |  | 0.2 |  |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high |  |  | Full |  | 1.7 |  | $\mathrm{V}_{+}$ | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | Full |  | 0 |  | 0.7 | V |

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

## Electrical Characteristics for 2.5-V Supply (continued)

$\mathrm{V}_{+}=2.3 \mathrm{~V}$ to $2.7 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{IH}}, \mathrm{I}_{\mathrm{IL}}$ | Input leakage current | $\mathrm{V}_{1}=\mathrm{V}_{+}$or 0 |  | $25^{\circ} \mathrm{C}$ | 2.7 V | -0.1 | 0.05 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -1 |  | 1 |  |
| $\mathrm{Q}_{\mathrm{C}}$ | Charge injection | $\begin{aligned} & \mathrm{V}_{\mathrm{GEN}}=0, \\ & \mathrm{R}_{\mathrm{GEN}}=0, \end{aligned}$ | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=0.1 \mathrm{nF}, \\ & \text { see Figure } 26 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 1 |  | pC |
| $\mathrm{C}_{\text {NC(OFF) }}$, <br> $\mathrm{C}_{\mathrm{NO} \text { (OFF) }}$ | NC, NO OFF capacitance | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{+}$or GND, | Switch OFF, <br> see Figure 20 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 3 |  | pF |
| $\mathrm{C}_{\text {COM (OFF) }}$ | COM OFF capacitance | $\mathrm{V}_{\text {COM }}=\mathrm{V}_{+}$or GND, | Switch OFF, <br> see Figure 20 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 9 |  | pF |
| $\mathrm{C}_{\mathrm{NC}(\mathrm{ON})}$, $\mathrm{C}_{\mathrm{NO}(\mathrm{ON})}$ | NC, NO <br> ON capacitance | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{+}$or GND, | Switch ON, see Figure 20 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 16 |  | pF |
| $\mathrm{C}_{\text {COM(ON) }}$ | COM <br> ON capacitance | $\mathrm{V}_{\text {COM }}=\mathrm{V}_{+}$or GND, | Switch ON, see Figure 20 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 16 |  | pF |
| $\mathrm{C}_{1}$ | Digital input capacitance | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{+}$or GND, | See Figure 20 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 3 |  | pF |
| BW | Bandwidth | $\mathrm{R}_{\mathrm{L}}=50 \Omega$, | Switch ON, see Figure 22 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | 300 |  | MHz |
| $\mathrm{O}_{\text {ISo }}$ | OFF isolation | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \end{aligned}$ | Switch OFF, see Figure 23 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | -48 |  | dB |
| $\mathrm{X}_{\text {TALK }}$ | Crosstalk | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \end{aligned}$ | Switch ON, see Figure 24 | $25^{\circ} \mathrm{C}$ | 2.5 V |  | -48 |  | dB |
| $\mathrm{X}_{\text {TALK(ADJ) }}$ | Crosstalk adjacent | $\begin{aligned} & R_{\mathrm{L}}=50 \Omega, \\ & \mathrm{f}=10 \mathrm{MHz}, \end{aligned}$ | Switch ON, see Figure 25 | $25^{\circ} \mathrm{C}$ | 3.3 V |  | -81 |  | dB |
| THD | Total harmonic distortion | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=600 \Omega, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \end{aligned}$ | $\begin{aligned} & \mathrm{f}=20 \mathrm{~Hz} \text { to } 20 \mathrm{kHz}, \\ & \text { see Figure } 27 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 2.5 V |  | .33\% |  |  |
| $I_{+}$ | Positive supply current | $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{+}$or GND, | Switch ON or OFF | $25^{\circ} \mathrm{C}$ | 2.7 V |  | 2.5 | 7 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  |  |  | 10 |  |

### 6.7 Electrical Characteristics for 2.1-V Supply

$\mathrm{V}_{+}=2.00 \mathrm{~V}$ to $2.20 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS | $\mathbf{T}_{\mathbf{A}}$ | $\mathbf{V}_{+}$ | MIN | TYP | MAX |
| :--- | :--- | :--- | :--- | :--- | ---: | :---: | :---: |
| $\mathrm{V}_{\text {IH }}$ | UnPut logic high |  | Full |  | 1.2 | 4.3 | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  | Full |  | 0 | 0.5 | V |

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

### 6.8 Electrical Characteristics for 1.8-V Supply

$\mathrm{V}_{+}=1.65 \mathrm{~V}$ to $1.95 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{COM}}, \mathrm{V}_{\mathrm{NC}}, \mathrm{V}_{\mathrm{NO}}$ | Analog signal range |  |  |  |  | 0 |  | $V_{+}$ | V |
| $\mathrm{r}_{\text {on }}$ | ON-state resistance | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 1.65 V |  | 5.5 | 17 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 32 |  |
| $\Delta r_{\text {on }}$ | ON-state resistance match between channels | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=1.5 \mathrm{~V}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 1.65 V |  | 0.3 | 1 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 1.2 |  |
| $\mathrm{r}_{\text {on(flat) }}$ | ON-state resistance flatness | $\begin{aligned} & 0 \leq\left(\mathrm{V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}\right) \leq \mathrm{V}_{+}, \\ & \mathrm{I}_{\mathrm{COM}}=-32 \mathrm{~mA}, \end{aligned}$ | Switch ON, see Figure 17 | $25^{\circ} \mathrm{C}$ | 1.65 V |  | 2.7 | 5.5 | $\Omega$ |
|  |  |  |  | Full |  |  |  | 7.3 |  |

[^0]
## Electrical Characteristics for 1.8-V Supply (continued)

$\mathrm{V}_{+}=1.65 \mathrm{~V}$ to $1.95 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ (unless otherwise noted) ${ }^{(1)}$

| PARAMETER |  | TEST CONDITIONS |  | T | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{OFF})}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{OFF})}$ | NC, NO OFF leakage current | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0.3 \mathrm{~V}$, <br> $\mathrm{V}_{\text {COM }}=1.65 \mathrm{~V}$, <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=1.65 \mathrm{~V}$, <br> $\mathrm{V}_{\text {COM }}=0.3 \mathrm{~V}$, | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 1.95 V | -0.25 | 0.03 | 0.25 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | $-4.5$ |  | 4.5 |  |
|  |  | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=1.95 \mathrm{~V}$ to 0 V , <br> $\mathrm{V}_{\text {COM }}=0 \mathrm{~V}$ to 1.95 V , <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0 \mathrm{~V}$ to 1.95 V , <br> $\mathrm{V}_{\text {COM }}=1.95 \mathrm{~V}$ to 0 V , | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -0.4 | 0.01 | 0.4 |  |
|  |  |  |  | Full |  | -6.5 |  | 6.5 |  |
| $I_{\text {Com(OFF) }}$ | COM OFF leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=1.65 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=0.3 \mathrm{~V}, \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=0.3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=1.65 \mathrm{~V} \text {, } \end{aligned}$ | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 1.95 V | -0.4 | 0.02 | 0.4 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -0.9 |  | 0.9 |  |
|  |  | $\mathrm{V}_{\mathrm{COM}}=0 \mathrm{~V}$ to 1.95 V , <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=1.95 \mathrm{~V}$ to 0 V , <br> or <br> $\mathrm{V}_{\text {COM }}=1.95 \mathrm{~V}$ to 0 , <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0$ to 1.95 V , | Switch OFF, see Figure 18 | $25^{\circ} \mathrm{C}$ | 0 V | -0.4 | 0.02 | 0.4 |  |
|  |  |  |  | Full |  | -4.5 |  | 4.5 |  |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{ON})}$, $\mathrm{I}_{\mathrm{NO}(\mathrm{ON})}$ | NC, NO ON leakage current | $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=0.3 \mathrm{~V}$, <br> $\mathrm{V}_{\text {Com }}=$ Open, <br> or <br> $\mathrm{V}_{\mathrm{NC}}$ or $\mathrm{V}_{\mathrm{NO}}=1.65 \mathrm{~V}$, <br> $V_{C O M}=$ Open, | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 1.95 V | -2. | 0.02 | 2 |  |
|  |  |  |  | Full |  | -2 | 0.02 | 2 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {Com(ON) }}$ | COM <br> ON leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=0.3 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \\ & \text { or } \\ & \mathrm{V}_{\mathrm{COM}}=1.65 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{NC}} \text { or } \mathrm{V}_{\mathrm{NO}}=\text { Open, } \end{aligned}$ | Switch ON, see Figure 19 | $25^{\circ} \mathrm{C}$ | 1.95 V | -4.5 |  | 4.5 |  |
|  |  |  |  | Full |  |  |  |  | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\mathrm{IH}}$ | Input logic high | $\mathrm{V}_{1}=\mathrm{V}_{+}$or GND |  | Full | 1.95 V | 1 |  | 3.6 | V |
| $\mathrm{V}_{\text {IL }}$ | Input logic low |  |  | Full | 1.95 V | 0 |  | 0.4 | V |
| $\mathrm{I}_{\mathrm{IH}}, \mathrm{I}_{\mathrm{IL}}$ | Input leakage current | $\mathrm{V}_{1}=\mathrm{V}_{+}$or 0 |  | $25^{\circ} \mathrm{C}$ | 1.95 V | -0.1 | 0.01 | 0.1 | $\mu \mathrm{A}$ |
|  |  |  |  | Full |  | -2.1 |  | 2.1 |  |

### 6.9 Switching Characteristics for 3.3-V Supply

over operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{ON}}$ | Turnon time | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=2 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{L}}=300 \Omega, \end{aligned}$ | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \text { see Figure } 21 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 3.3 V | 2.5 | 3.5 | 8 | ns |
|  |  |  |  | Full | $\begin{aligned} & 3 \mathrm{~V} \text { to } \\ & 3.6 \mathrm{~V} \end{aligned}$ | 2.5 |  | 9 |  |
| toff | Turnoff time | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=2 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{L}}=300 \Omega, \end{aligned}$ | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}, \\ & \text { see Figure } 21 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 3.3 V | 0.5 | 2 | 6.5 | ns |
|  |  |  |  | Full | $\begin{aligned} & 3 \mathrm{~V} \text { to } \\ & 3.6 \mathrm{~V} \end{aligned}$ | 0.5 |  | 7 |  |

### 6.10 Switching Characteristics for 2.5-V Supply

over operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{ON}}$ | Turnon time | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=1.5 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{L}}=300 \Omega, \end{aligned}$ | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF},$ <br> see Figure 21 | $25^{\circ} \mathrm{C}$ | 2.5 V | 2.5 | 5 | 9.5 | ns |
|  |  |  |  | Full | $\begin{gathered} 2.3 \mathrm{~V} \text { to } \\ 2.7 \mathrm{~V} \end{gathered}$ | 2.5 |  | 10.5 |  |
| toff | Turnoff time | $\begin{aligned} & \mathrm{V}_{\mathrm{COM}}=1.5 \mathrm{~V}, \\ & \mathrm{R}_{\mathrm{L}}=300 \Omega, \end{aligned}$ | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF},$ <br> see Figure 21 | $25^{\circ} \mathrm{C}$ | 2.5 V | 0.5 | 3 | 7.5 | ns |
|  |  |  |  | Full | $\begin{aligned} & 2.3 \mathrm{~V} \text { to } \\ & 2.7 \mathrm{~V} \end{aligned}$ | 0.5 |  | 9 |  |

### 6.11 Switching Characteristics for 1.8-V Supply

over operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | TA | $\mathrm{V}_{+}$ | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{ON}}$ | Turnon time | $\begin{aligned} & V_{\text {COM }}=V_{+}, \\ & R_{L}=50 \Omega, \end{aligned}$ | $\mathrm{C}_{\mathrm{L}}=35 \mathrm{pF},$ <br> see Figure 21 | $25^{\circ} \mathrm{C}$ | 1.8 V |  | 14.1 | 49.3 | ns |
|  |  |  |  | Full | $\begin{gathered} 1.65 \mathrm{~V} \\ \text { to } \\ 1.95 \mathrm{~V} \end{gathered}$ |  | 49.3 | 56.7 |  |
| toff | Turnoff time | $\begin{aligned} & V_{\text {COM }}=V_{+}, \\ & R_{L}=50 \Omega, \end{aligned}$ | $\begin{aligned} & C_{L}=35 \mathrm{pF}, \\ & \text { see Figure } 21 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 1.8 V |  | 16.1 | 26.5 | ns |
|  |  |  |  | Full | $\begin{gathered} 1.65 \mathrm{~V} \\ \text { to } \\ 1.95 \mathrm{~V} \end{gathered}$ |  |  | 31.2 |  |
|  | Break-beforemake time | $\begin{aligned} & \mathrm{V}_{\mathrm{NC}}=\mathrm{V}_{\mathrm{NO}}=\mathrm{V}_{+} / 2, \\ & \mathrm{R}_{\mathrm{L}}=50 \Omega, \end{aligned}$ | $\begin{aligned} & C_{L}=35 \mathrm{pF}, \\ & \text { see Figure } 21 \end{aligned}$ | $25^{\circ} \mathrm{C}$ | 1.8 V | 5.3 | 18.4 | 58 | ns |
| $t_{\text {BBM }}$ |  |  |  | Full | $\begin{gathered} 1.65 \mathrm{~V} \\ \text { to } \\ 1.95 \mathrm{~V} \\ \hline \end{gathered}$ |  |  | 58 |  |

### 6.12 Typical Characteristics



Figure 1. $\mathrm{r}_{\text {on }} \mathrm{vs} \mathrm{V}_{\text {com }}\left(\mathrm{V}_{+}=3.3 \mathrm{~V}\right)$


Figure 3. Leakage Current vs Temperature ( $\mathrm{V}_{+}=3.6 \mathrm{~V}$ )


Figure 5. Charge Injection $\left(Q_{c}\right)$ vs $\mathrm{V}_{\text {com }}$


Figure 2. $\mathrm{r}_{\mathrm{on}}$ vs $\mathrm{V}_{\text {com }}\left(\mathrm{V}_{+}=\mathbf{2 . 5} \mathrm{V}\right)$


Figure 4. Leakage Current vs Temperature ( $\mathrm{V}_{+}=1.8 \mathrm{~V}$ )


Figure 6. Charge Injection $\left(\mathrm{Q}_{\mathrm{C}}\right)$ vs $\mathrm{V}_{\text {com }}\left(\mathrm{V}_{+}=1.8 \mathrm{~V}\right)$

## Typical Characteristics (continued)



Figure 7. $\mathrm{t}_{\mathrm{ON}}$ and $\mathrm{t}_{\text {OFF }}$ vs Supply Voltage


Figure 9. Logic-Level Threshold vs $\mathbf{V}_{+}$


Figure 11. OFF Isolation vs Frequency ( $\mathrm{V}_{+}=1.8 \mathrm{~V}$ )


Figure 8. $\mathrm{t}_{\mathrm{ON}}$ and $\mathrm{t}_{\mathrm{OFF}}$ vs Temperature ( $\mathrm{V}_{+}=3.3 \mathrm{~V}$ )


Figure 10. Gain vs Frequency Bandwidth ( $\mathrm{V}_{+}=3.3 \mathrm{~V}$ )


Figure 12. Crosstalk Adjacent vs Frequency ( $\mathrm{V}_{+}=1.8 \mathrm{~V}$ )

## Typical Characteristics (continued)



## 7 Parameter Measurement Information



Figure 17. ON-State Resistance ( $\mathrm{r}_{\mathrm{on}}$ )


Figure 18. OFF-State Leakage Current (ICOM(OFF), $\left.I_{\text {NC(OFF) }}, I_{\text {NO(OFF) }}\right)$


Figure 19. ON-State Leakage Current (ICOM(ON), $\left.I_{\mathrm{NC}(\mathrm{ON})}\right)$

## Parameter Measurement Information (continued)


$\mathrm{V}_{\mathrm{BIAS}}=\mathrm{V}_{+}$or GND
$\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\mathrm{IL}}$
Capacitance is measured at NC, NO, COM, and IN inputs during ON and OFF conditions.

Figure 20. Capacitance ( $\left.\mathrm{C}_{\mathrm{l}}, \mathrm{C}_{\mathrm{COM}(\mathrm{OFF})}, \mathrm{C}_{\mathrm{COM}(\mathrm{ON})}, \mathrm{C}_{\mathrm{NC}(\mathrm{OFF})}, \mathrm{C}_{\mathrm{NC}(\mathrm{ON})}\right)$

(1) All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}}<5 \mathrm{~ns}$, $\mathrm{t}_{\mathrm{f}}<5 \mathrm{~ns}$.
(2) $\mathrm{C}_{\mathrm{L}}$ includes probe and jig capacitance.
(3) See Electrical Characteristics for $\mathrm{V}_{\text {COM }}$.

Figure 21. Turnon ( $\mathrm{t}_{\mathrm{ON}}$ ) and Turnoff Time ( $\mathrm{t}_{\mathrm{OFF}}$ )


Figure 22. Bandwidth (BW)

## Parameter Measurement Information (continued)



Channel OFF: NC to COM
$\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{+}$or GND

> Network Analyzer Setup
> Source Power $=0 \mathrm{dBm}$ $(632-\mathrm{mV}$ P-P at $50-\Omega$ load $)$ DC Bias $=350 \mathrm{mV}$

Figure 23. OFF Isolation ( $\mathrm{O}_{\mathrm{Iso}}$ )


Channel ON: NC to COM Channel OFF: NO to COM $\mathrm{V}_{\mathrm{I}}=\mathrm{V}_{+}$or GND

Network Analyzer Setup
Source Power $=0 \mathrm{dBm}$ (632-mV P-P at $50-\Omega$ load)
DC Bias $=350 \mathrm{mV}$
Figure 24. Crosstalk ( $\mathrm{X}_{\text {TALK }}$ )


Channel ON: NC to COM

Network Analyzer Setup
Source Power $=0 \mathrm{dBm}$ ( 632 mV P-P at $50 \Omega$ load)

DC Bias $=350 \mathrm{mV}$

Figure 25. Crosstalk Adjacent

## Parameter Measurement Information (continued)


$\mathrm{V}_{\text {com }}$


$$
\begin{aligned}
& \mathrm{V}_{\mathrm{GEN}}=0 \text { to } \mathrm{V}_{+} \\
& \mathrm{R}_{\mathrm{GEN}}=0 \\
& \mathrm{C}_{\mathrm{L}}=0.1 \mathrm{nF} \\
& \mathrm{Q}_{\mathrm{C}}=\mathrm{C}_{\mathrm{L}} \times \Delta \mathrm{V}_{\mathrm{COM}} \\
& \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IH}} \text { or } \mathrm{V}_{\mathrm{IL}}
\end{aligned}
$$

(1) $C_{L}$ includes probe and jig capacitance.
(2) All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}}<5 \mathrm{~ns}$, $\mathrm{t}_{\mathrm{f}}<5 \mathrm{~ns}$.

Figure 26. Charge Injection ( $\mathbf{Q}_{\mathrm{C}}$ )

(1) $C_{L}$ includes probe and jig capacitance.

Figure 27. Total Harmonic Distortion (THD)

## 8 Detailed Description

### 8.1 Overview

The TS3A5018 is a quad single-pole-double-throw (SPDT) solid-state analog switch. The TS3A5018, like all analog switches, is bidirectional. When powered on, each COM pin is connected to its respective NC pin. For this device, NC stands for normally closed and NO stands for normally open. The switch is enabled when EN is low. If IN is also low, COM is connected to NC . If IN is high, COM is connected to NO.

The TS3A5018 is a break-before-make switch. This means that during switching, a connection is broken before a new connection is established. The NC and NO pins are never connected to each other.

### 8.2 Functional Block Diagram (Each Switch)



### 8.3 Feature Description

The low ON-state resistance, ON-state resistance matching, and charge injection in the TS3A5018 make this switch an excellent choice for analog signals that require minimal distortion. In addition, the low THD allows audio signals to be preserved more clearly as they pass through the device.

The $1.8-\mathrm{V}$ to $3.6-\mathrm{V}$ operation allows compatibility with more logic levels, and the bidirectional I/Os can pass analog signals from 0 V to $\mathrm{V}_{+}$with low distortion.

### 8.4 Device Functional Modes

Table 1. Function Table

| $\overline{\text { EN }}$ | IN | NO TO COM, <br> COM TO NO | NC TO COM, <br> COM TO NC |
| :---: | :---: | :---: | :---: |
| L | L | OFF | ON |
| L | H | ON | OFF |
| $H$ | X | OFF | OFF |

## 9 Application and Implementation

## NOTE

Information in the following applications sections is not part of the Tl component specification, and TI does not warrant its accuracy or completeness. Tl's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TS3A5018 can be used in a variety of customer systems. The TS3A5018 can be used anywhere multiple analog or digital signals must be selected to pass across a single line.

### 9.2 Typical Application



Figure 28. System Schematic for TS3A5018

### 9.2.1 Design Requirements

In this particular application, $\mathrm{V}_{+}$was 1.8 V , although $\mathrm{V}_{+}$is allowed to be any voltage specified in Recommended Operating Conditions. A decoupling capacitor is recommended on the $\mathrm{V}_{+}$pin. See Power Supply Recommendations for more details.

### 9.2.2 Detailed Design Procedure

In this application, EN and IN are, by default, pulled low to GND. Choose these resistor sizes based on the current driving strength of the GPIO, the desired power consumption, and the switching frequency (if applicable). If the GPIO is open-drain, use pullup resistors instead.

### 9.2.3 Application Curve



Figure 29. Gain vs Frequency Bandwidth $\left(\mathrm{V}_{+}=1.8 \mathrm{~V}\right)$

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the Recommended Operating Conditions.
Each $\mathrm{V}_{\mathrm{CC}}$ terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a $0.1-\mu \mathrm{F}$ bypass capacitor is recommended. If there are multiple pins labeled $\mathrm{V}_{\mathrm{CC}}$, then a $0.01-\mu \mathrm{F}$ or $0.022-\mu \mathrm{F}$ capacitor is recommended for each $\mathrm{V}_{\mathrm{CC}}$ because the VCC pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example $\mathrm{V}_{C C}$ and $\mathrm{V}_{\mathrm{DD}}$, a $0.1-\mu \mathrm{F}$ bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. $0.1-\mu \mathrm{F}$ and $1-\mu \mathrm{F}$ capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

## 11 Layout

### 11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a $90^{\circ}$ angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace - resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. Figure 30 shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

Unused switch I/Os, such as NO, NC, and COM, can be left floating or tied to GND. However, the IN and EN pins must be driven high or low. Due to partial transistor turnon when control inputs are at threshold levels, floating control inputs can cause increased $\mathrm{I}_{\mathrm{CC}}$ or unknown switch selection states.

### 11.2 Layout Example



Figure 30. Trace Example

## 12 Device and Documentation Support

### 12.1 Device Support

### 12.1.1 Device Nomenclature

Table 2. Parameter Description

| SYMBOL | DESCRIPTION |
| :---: | :---: |
| $\mathrm{V}_{\text {COM }}$ | Voltage at COM |
| $\mathrm{V}_{\mathrm{NC}}$ | Voltage at NC |
| $\mathrm{V}_{\mathrm{NO}}$ | Voltage at NO |
| $\mathrm{r}_{\text {on }}$ | Resistance between COM and NC or NO ports when the channel is ON |
| $\Delta r_{\text {on }}$ | Difference of $r_{\text {on }}$ between channels in a specific device |
| $r_{\text {on(flat) }}$ | Difference between the maximum and minimum value of $r_{\text {on }}$ in a channel over the specified range of conditions |
| $\mathrm{I}_{\text {NC(OFF) }}$ | Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state |
| $\mathrm{I}_{\mathrm{NC}(\mathrm{ON})}$ | Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) open |
| $\mathrm{I}_{\text {NO(OFF) }}$ | Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state |
| $\mathrm{I}_{\mathrm{NO}(\mathrm{ON})}$ | Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) open |
| $\mathrm{I}_{\text {COM (OFF) }}$ | Leakage current measured at the COM port, with the corresponding channel (COM to NC or NO) in the OFF state |
| $\mathrm{I}_{\text {COM(ON }}$ | Leakage current measured at the COM port, with the corresponding channel (COM to NC or NO) in the ON state and the output (NC or NO) open |
| $\mathrm{V}_{\text {IH }}$ | Minimum input voltage for logic high for the control input (IN, $\overline{\mathrm{EN}}$ ) |
| $\mathrm{V}_{\mathrm{IL}}$ | Maximum input voltage for logic low for the control input (IN, EN) |
| $V_{1}$ | Voltage at the control input (IN, EN) |
| $\mathrm{I}_{\mathrm{IH}}, \mathrm{I}_{\mathrm{IL}}$ | Leakage current measured at the control input (IN, $\overline{\mathrm{EN}}$ ) |
| ton | Turnon time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output NC or NO) signal when the switch is turning ON. |
| toff | Turnoff time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog output (NC or NO) signal when the switch is turning OFF. |
| $Q_{C}$ | Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NC or NO) output. This is measured in coulomb (C) and measured by the total charge induced due to switching of the control input. Charge injection, $\mathrm{Q}_{\mathrm{C}}=\mathrm{C}_{\mathrm{L}} \times \Delta \mathrm{V}_{\mathrm{COM}}, \mathrm{C}_{\mathrm{L}}$ is the load capacitance and $\Delta \mathrm{V}_{\mathrm{COM}}$ is the change in analog output voltage. |
| $\mathrm{C}_{\mathrm{NC} \text { (OFF) }}$ | Capacitance at the NC port when the corresponding channel (NC to COM) is OFF |
| $\mathrm{C}_{\mathrm{NC}(\mathrm{ON})}$ | Capacitance at the NC port when the corresponding channel (NC to COM) is ON |
| $\mathrm{C}_{\mathrm{NO} \text { (OFF) }}$ | Capacitance at the NC port when the corresponding channel (NO to COM) is OFF |
| $\mathrm{C}_{\mathrm{NO}(\mathrm{ON})}$ | Capacitance at the NC port when the corresponding channel (NO to COM) is ON |
| $\mathrm{C}_{\text {COM (OFF) }}$ | Capacitance at the COM port when the corresponding channel (COM to NC) is OFF |
| $\mathrm{C}_{\text {COM(ON) }}$ | Capacitance at the COM port when the corresponding channel (COM to NC) is ON |
| $\mathrm{Cl}_{1}$ | Capacitance of control input (IN, $\overline{\mathrm{EN}}$ ) |
| $\mathrm{O}_{\text {ISo }}$ | OFF isolation of the switch is a measurement of OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NC to COM) in the OFF state. |
| $\mathrm{X}_{\text {talk }}$ | Crosstalk is a measurement of unwanted signal coupling from an ON channel to an OFF channel (NC1 to NO1). Adjacent crosstalk is a measure of unwanted signal coupling from an ON channel to an adjacent ON channel (NC1 to NC2). This is measured in a specific frequency and in dB. |
| BW | Bandwidth of the switch. This is the frequency in which the gain of an ON channel is -3 dB below the DC gain. |
| THD | Total harmonic distortion describes the signal distortion caused by the analog switch. This is defined as the ratio of root mean square (RMS) value of the second, third, and higher harmonic to the absolute magnitude of the fundamental harmonic. |
| $I_{+}$ | Static power-supply current with the control (IN) pin at $\mathrm{V}_{+}$or GND |

### 12.2 Documentation Support

### 12.2.1 Related Documentation

For related documentation, see the following:

- Implications of Slow or Floating CMOS Inputs, SCBA004


### 12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.
TI E2ETM Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.5 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

### 12.6 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.7 Glossary

SLYZ022 - TI Glossary.
This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TS3A5018D | ACTIVE | SOIC | D | 16 | 40 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | TS3A5018 | Samples |
| TS3A5018DBQR | ACTIVE | SSOP | DBQ | 16 | 2500 | RoHS \& Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | YA018 | Samples |
| TS3A5018DBQRG4 | ACTIVE | SSOP | DBQ | 16 | 2500 | RoHS \& Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | YA018 | Samples |
| TS3A5018DE4 | ACTIVE | SOIC | D | 16 | 40 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | TS3A5018 | Samples |
| TS3A5018DGVR | ACTIVE | TVSOP | DGV | 16 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | YA018 | Samples |
| TS3A5018DR | ACTIVE | SOIC | D | 16 | 2500 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | TS3A5018 | Samples |
| TS3A5018DRE4 | ACTIVE | SOIC | D | 16 | 2500 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | TS3A5018 | Samples |
| TS3A5018PW | ACTIVE | TSSOP | PW | 16 | 90 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | YA018 | Samples |
| TS3A5018PWG4 | ACTIVE | TSSOP | PW | 16 | 90 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | YA018 | Samples |
| TS3A5018PWR | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | YA018 | Samples |
| TS3A5018PWRE4 | ACTIVE | TSSOP | PW | 16 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | YA018 | Samples |
| TS3A5018RGYR | ACTIVE | VQFN | RGY | 16 | 3000 | RoHS \& Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | YA018 | Samples |
| TS3A5018RGYRG4 | ACTIVE | VQFN | RGY | 16 | 3000 | RoHS \& Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 85 | YA018 | Samples |
| TS3A5018RSVR | ACTIVE | UQFN | RSV | 16 | 3000 | RoHS \& Green | NIPDAU \| NIPDAUAG | Level-1-260C-UNLIM | -40 to 85 | ZUN | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

[^1]RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $\mathbf{W 1}(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | $\mathbf{W}$ <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TS3A5018DBQR | SSOP | DBQ | 16 | 2500 | 330.0 | 12.5 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| TS3A5018DGVR | TVSOP | DGV | 16 | 2000 | 330.0 | 12.4 | 6.8 | 4.0 | 1.6 | 8.0 | 12.0 | Q1 |
| TS3A5018DR | SOIC | D | 16 | 2500 | 330.0 | 16.4 | 6.5 | 10.3 | 2.1 | 8.0 | 16.0 | Q1 |
| TS3A5018PWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TS3A5018RGYR | VQFN | RGY | 16 | 3000 | 330.0 | 12.4 | 3.8 | 4.3 | 1.5 | 8.0 | 12.0 | Q1 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 180.0 | 13.2 | 2.1 | 2.9 | 0.75 | 4.0 | 12.0 | Q1 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 177.8 | 12.4 | 2.0 | 2.8 | 0.7 | 4.0 | 12.0 | Q1 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 180.0 | 12.4 | 2.1 | 2.9 | 0.75 | 4.0 | 12.0 | Q1 |

PACKAGE MATERIALS INFORMATION
INSTRUMENTS

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TS3A5018DBQR | SSOP | DBQ | 16 | 2500 | 340.5 | 338.1 | 20.6 |
| TS3A5018DGVR | TVSOP | DGV | 16 | 2000 | 853.0 | 449.0 | 35.0 |
| TS3A5018DR | SOIC | D | 16 | 2500 | 340.5 | 336.1 | 32.0 |
| TS3A5018PWR | TSSOP | PW | 16 | 2000 | 853.0 | 449.0 | 35.0 |
| TS3A5018RGYR | VQFN | RGY | 16 | 3000 | 853.0 | 449.0 | 35.0 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 184.0 | 184.0 | 19.0 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 202.0 | 201.0 | 28.0 |
| TS3A5018RSVR | UQFN | RSV | 16 | 3000 | 200.0 | 183.0 | 25.0 |

## TUBE



B - Alignment groove width
*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | $\mathbf{L}(\mathbf{m m})$ | $\mathbf{W}(\mathbf{m m})$ | $\mathbf{T}(\boldsymbol{\mu m})$ | $\mathbf{B}(\mathbf{m m})$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TS3A5018D | D | SOIC | 16 | 40 | 507 | 8 | 3940 | 4.32 |
| TS3A5018DE4 | D | SOIC | 16 | 40 | 507 | 8 | 3940 | 4.32 |
| TS3A5018PW | PW | TSSOP | 16 | 90 | 530 | 10.2 | 3600 | 3.5 |
| TS3A5018PWG4 | PW | TSSOP | 16 | 90 | 530 | 10.2 | 3600 | 3.5 |

D (R-PDSO-G16)


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.

C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed $0.006(0,15)$ each side.
D Body width does not include interlead flash. Interlead flash shall not exceed $0.017(0,43)$ each side.
E. Reference JEDEC MS-012 variation AC.

D (R-PDSO-G16)


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL SCALE: 10X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.


| PIM ** | $\mathbf{1 4}$ | $\mathbf{1 6}$ | $\mathbf{2 0}$ | $\mathbf{2 4}$ | $\mathbf{3 8}$ | $\mathbf{4 8}$ | $\mathbf{5 6}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| A MAX | 3,70 | 3,70 | 5,10 | 5,10 | 7,90 | 9,80 | 11,40 |
| A MIN | 3,50 | 3,50 | 4,90 | 4,90 | 7,70 | 9,60 | 11,20 |

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
D. Falls within JEDEC: $24 / 48$ Pins - MO-153

14/16/20/56 Pins - MO-194


## NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.


SOLDER MASK DETAILS

## NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE
BASED ON . 005 INCH [0.127 MM] THICK STENCIL
SCALE:8X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

RGY (R-PVQFN-N16) PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).
For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.


Bottom View

Exposed Thermal Pad Dimensions

NOTE: All linear dimensions are in millimeters


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http: //www.ti.com>.
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.


NOTES: (continued)
3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).


SOLDER PASTE EXAMPLE BASED ON 0.125 MM THICK STENCIL SCALE: 25X

NOTES: (continued)
4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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[^0]:    (1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

[^1]:    ${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

